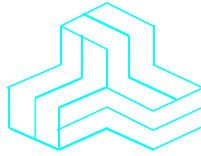


ENGINEERING TEST REPORT



IXM MYCRO ENXP
Model: IXM051
FCC ID: S38-MENXP

Applicant:

Invoxium Access Inc.
#5 – 205 Riviera Drive
Markham, Ontario
Canada L3R 5J8

In Accordance With
Federal Communications Commission (FCC)
Part 15, Subpart C, Section 15.209

UltraTech's File No.: INVX-002F15C209FP2

This Test report is Issued under the Authority of
Tri M. Luu
Vice President of Engineering
UltraTech Group of Labs

Date: February 13, 2014

Report Prepared by: Dan Huynh

Tested by: Hung Trinh

Issued Date: February 13, 2014

Test Dates: January 3 & 9, 2014

- The results in this Test Report apply only to the sample(s) tested, and the sample tested is randomly selected.
- This report must not be used by the client to claim product endorsement by NVLAP or any agency of the US Government.

UltraTech

3000 Bristol Circle, Oakville, Ontario, Canada, L6H 6G4

Tel.: (905) 829-1570 Fax.: (905) 829-8050

Website: www.ultratech-labs.com, Email: vic@ultratech-labs.com, Email: tri@ultratech-labs.com



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NVLAP LAB
CODE 200093-0



SL2-IN-E-
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CA2049



TL363_B



TPTDP
DA1300

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EXHIBIT 1. INTRODUCTION

1.1. SCOPE

Reference:	FCC Part 15, Subpart C
Title:	Code of Federal Regulations (CFR), Title 47, Telecommunication - Part 15
Purpose of Test:	To gain FCC Equipment Certification for FCC Part 15C.
Test Procedures:	ANSI C63.4 and ANSI C63.10
Environmental Classification:	Commercial, industrial or business environment

1.2. RELATED SUBMITTAL(S)/GRANT(S)

None.

1.3. NORMATIVE REFERENCES

Publication	Year	Title
FCC 47 CFR 15	2013	Code of Federal Regulations (CFR), Title 47 – Telecommunication
ANSI C63.4	2009	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 KHz to 40 GHz
ANSI C63.10	2009	American National Standard for Testing Unlicensed Wireless Devices
CISPR 22 EN 55022	2008-09, Edition 6.0 2006	Information Technology Equipment - Radio Disturbance Characteristics - Limits and Methods of Measurement
CISPR 16-1-1 +A1 +A2	2006 2006 2007	Specification for radio disturbance and immunity measuring apparatus and methods. Part 1-1: Measuring Apparatus
CISPR 16-1-2 +A1 +A2	2003 2004 2006	Specification for radio disturbance and immunity measuring apparatus and methods. Part 1-2: Conducted disturbances

ULTRATECH GROUP OF LABS

3000 Bristol Circle, Oakville, Ontario, Canada L6H 6G4
Tel. #: 905-829-1570, Fax. #: 905-829-8050, Email: vic@ultratech-labs.com, Website: <http://www.ultratech-labs.com>

File #: INVX-002F15C209FP2
February 13, 2014

All test results contained in this engineering test report are traceable to National Institute of Standards and Technology (NIST)

EXHIBIT 2. PERFORMANCE ASSESSMENT

2.1. CLIENT INFORMATION

Applicant	
Name:	Invixium Access Inc.
Address:	205 Riviera Drive, Unit 5 Markam, ON Canada L3R 5J8
Contact Person:	Shiraz Kapadia Phone #: 647-282-1745 Fax #: N/A Email Address: SKapadia@invixium.com

Manufacturer	
Name:	Mara Technologies Inc.
Address:	5680 14th Avenue Markham, Ontario Canada L3S 3K8
Contact Person:	Matthew Ruscica Phone #: 1-905-201-1787 Fax #: 1-905-201-9114 Email Address: matthew@maratech.ca

2.2. EQUIPMENT UNDER TEST (EUT) INFORMATION

The following information (with the exception of the Date of Receipt) has been supplied by the applicant.

Brand Name:	Invixium Access Inc.
Product Name:	IXM MYCRO ENXP
Model Name or Number:	IXM051
Serial Number:	Test sample
Type of Equipment:	Part 15 Low Power Transmitter Below 1705 kHz
Input Power Supply Type:	12-24V DC external power supply
Primary User Functions of EUT:	Identifies person, either by fingerprint matching, or by card (proximity or contactless smart card), or both. Sends result of identification to Access Control Panel, or to Time and Attendance software application.

2.3. EUT'S TECHNICAL SPECIFICATIONS

Transmitter	
Equipment Type:	Portable
Intended Operating Environment:	Commercial, light industry & heavy industry
Power Supply Requirement:	5V DC
RF Output Power Rating:	49.35 dBμV/m peak at 3m distance
Operating Frequency Range:	125 kHz ± 3 kHz
20 dB Bandwidth:	4.57 kHz
Modulation Type:	Unmodulated carrier
Oscillator Frequencies:	125 kHz and 27.12 MHz
Antenna Connector Type:	840 uH coil, 125 kHz, Air Tuned Antenna

2.4. LIST OF EUT'S PORTS

Port Number	EUT's Port Description	Number of Identical Ports	Connector Type	Cable Type (Shielded/Non-shielded)
1	Wiegand Output (to Access Control Panel), 2 lines	1	Header	Non-shielded
2	Wiegand Input (from external RFID), 2 lines	1	Header	30cm, non-shielded
3	Ethernet !00 BASETX	1	RJ-45 on cable	Non-shielded
4	RS-485 (slave), 2 lines	1	Header	Non-shielded
5	RS-232, 2 lines	1	DB-9, socket on cable	Non-shielded
6	Form C Relay, 3 lines	1	Header	Non-shielded
7	GPO, 4 lines	1	Header	Non-shielded
8	GPI, 8 lines	1	Header	Non-shielded
9	GND, 5 lines	1	Header	Non-shielded
10	USB OTG (Service Port)	1	USB-Micro-AB	Shielded (service port)
11	Power Input (12-24V)	1	Header	Non-shielded
12	EGND	1	Header	Non-shielded

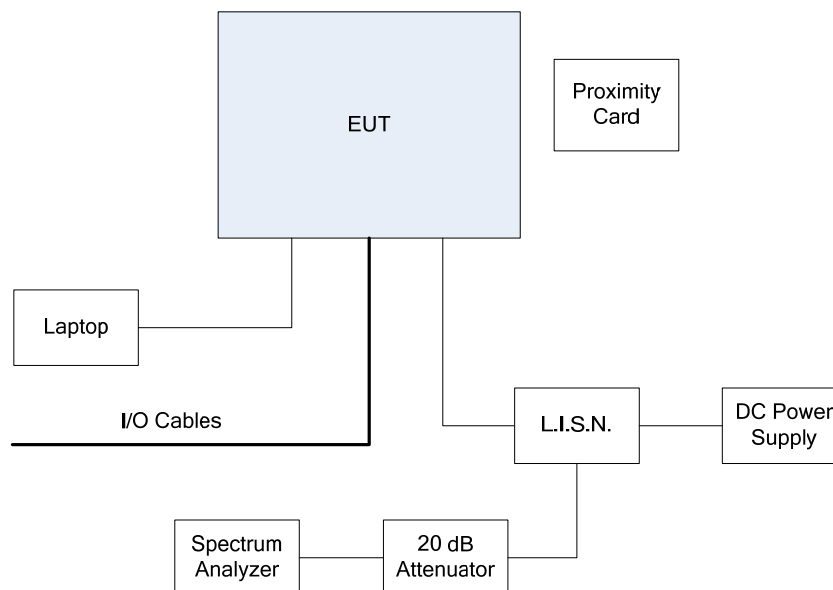
2.5. ANCILLARY EQUIPMENT

The EUT was tested while connected to the following representative configuration of ancillary equipment necessary to exercise the ports during tests:

Ancillary Equipment # 1	
Description:	Proximity Card
Brand Name:	EM Microelectronics SA
Model Name or Number:	EM4100
Serial Number:	N/A
Cable Length & Type:	N/A
Connected to EUT's Port:	N/A

2.6. TEST SETUP BLOCK DIAGRAM

2.6.1. Power Line Conducted Emission Test Setup



2.6.2. Radiated Emission Test Setup

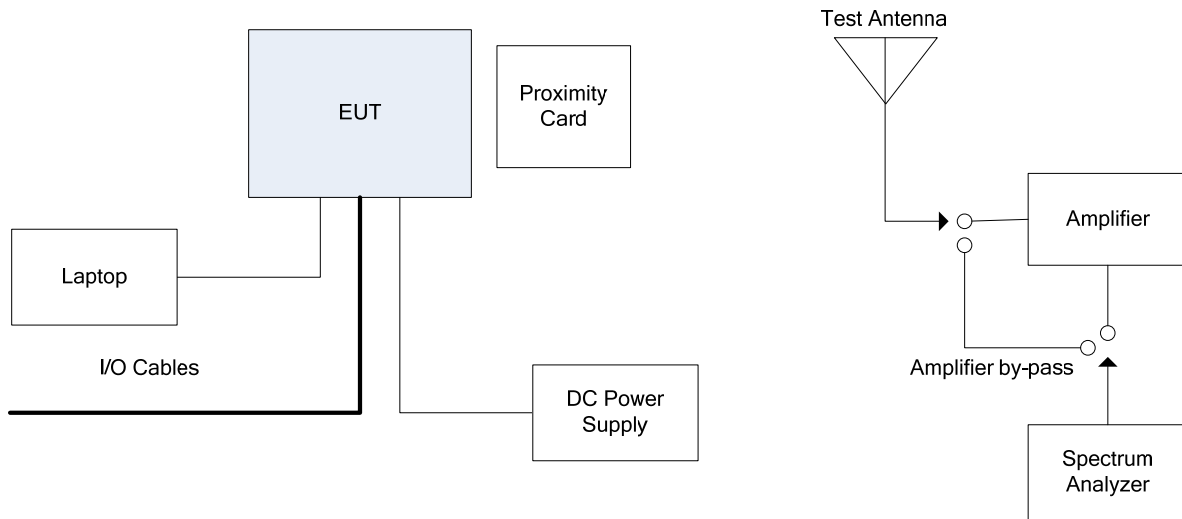


EXHIBIT 3. EUT OPERATING CONDITIONS AND CONFIGURATIONS DURING TESTS

3.1. CLIMATE TEST CONDITIONS

The climate conditions of the test environment are as follows:

Temperature:	21°C
Humidity:	51%
Pressure:	102 kPa
Power input source:	24 VDC

3.2. OPERATIONAL TEST CONDITIONS & ARRANGEMENT FOR TESTS

Operating Modes:	The EUT was configured for continuous transmission for the duration of testing.
Special Test Software:	N/A
Special Hardware Used:	N/A
Transmitter Test Antenna:	The EUT was tested with the antenna fitted in a manner typical of normal intended use as integral antenna equipment.

Transmitter Test Signals	
Frequency Band(s):	122 – 128 kHz
Test Frequency(ies):	127 kHz
RF Power Output:	49.35 dBµV/m peak at 3m distance
Normal Test Modulation:	Unmodulated carrier
Modulating Signal Source:	Internal

EXHIBIT 4. SUMMARY OF TEST RESULTS

4.1. LOCATION OF TESTS

All of the measurements described in this report were performed at Ultratech Group of Labs located in the city of Oakville, Province of Ontario, Canada.

- AC Power Line Conducted Emissions were performed in UltraTech's shielded room, 24'(L) by 16'(W) by 8'(H).
- Radiated Emissions were performed at the Ultratech's 3-10 TDK Semi-Anechoic Chamber situated in the Town of Oakville, province of Ontario. This test site been calibrated in accordance with ANSI C63.4, and found to be in compliance with the requirements of Sec. 2.948 of the FCC Rules. The descriptions and site measurement data of the Oakville 3-10 TDK Semi-Anechoic Chamber has been filed with FCC office (FCC File No.: 91038) and Industry Canada office (Industry Canada File No.: 2049A-3). Expiry Date: 2014-04-04.

4.2. APPLICABILITY & SUMMARY OF EMC EMISSION TEST RESULTS

FCC Section(s)	Test Requirements	Compliance (Yes/No)
15.203	Antenna Requirement	Yes*
15.207(a)	Power Line Conducted Emissions	Yes
15.209(a)	20 dB Bandwidth	Yes
15.209	Transmitter Radiated Emissions - Fundamental, Harmonic and Spurious Emissions	Yes

* The EUT complies with the requirement; it employs integral antenna.

4.3. MODIFICATIONS INCORPORATED IN THE EUT FOR COMPLIANCE PURPOSES

The following modifications were made for compliance:

1. On 4 wires between the radio board and antenna board:
 - a. Antenna_Smart_Card_0
 - b. Antenna_Smart_Card_1
 - c. Antenna_Smart_Card_2
 - d. Antenna_Smart_Card_3
 - NEOSID 140X050X130 ferrite bead (pearl-like)
2. On power supply lines pass-through ferrite Steward P/N 28A0350-0B2
3. On Ethernet lines, two loop through snap-on ferrite Steward P/N 28A3039-0A2

EXHIBIT 5. TEST DATA

5.1. POWERLINE CONDUCTED EMISSION [47 CFR 15.207(a)]

5.1.1. Limit(s)

The equipment shall meet the limits of the following table:

Frequency of emission (MHz)	Conducted Limits (dB μ V)	
	Quasi-peak	Average
0.15–0.5	66 to 56*	56 to 46*
0.5–5	56	46
5–30	60	50

*Decreases linearly with the logarithm of the frequency

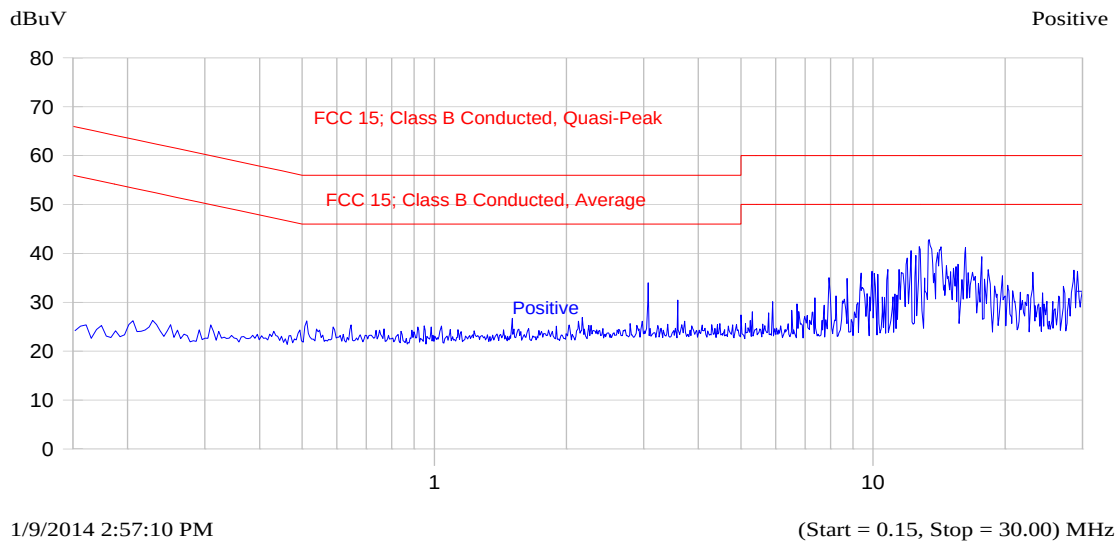
5.1.2. Method of Measurements

Refer to ANSI C63.4.

5.1.3. Test Data

Plot 5.1.3.1. Power Line Conducted Emissions
Line Voltage: 24 VDC; Line Tested: Positive

Current Graph

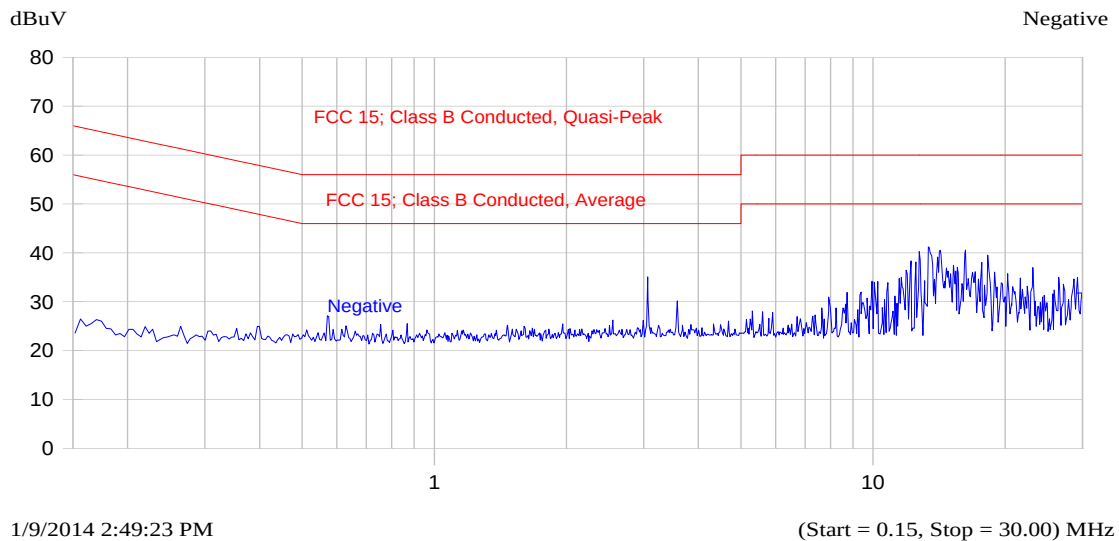


Current List

Frequency MHz	Peak dBuV	QP dBuV	Delta dB	QP-QP Limit	Avg dBuV	Delta Avg-Avg Limit	Trace Name
3.068	38.7	35.2	-20.8		31.7	-14.3	Positive
13.357	44.9	42.9	-17.1		39.9	-10.1	Positive

Plot 5.1.3.2. Power Line Conducted Emissions
Line Voltage: 24 VDC; Line Tested: Negative

Current Graph



Current List

Frequency MHz	Peak dBuV	QP dBuV	Delta QP-QP Limit dB	Avg dBuV	Delta Avg-Avg Limit dB	Trace Name
3.060	39.9	35.9	-20.1	32.7	-13.3	Negative
13.358	43.6	41.3	-18.7	37.7	-12.3	Negative

5.2. TRANSMITTER RADIATED EMISSIONS [47 CFR §§ 15.209 & 15.205]

5.2.1. Limit(s)

§ 15.209 Radiated emission limits; general requirements.

(a) Except as provided elsewhere in this subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30.0	30	30
30-88	100 **	3
88-216	150 **	3
216-960	200 **	3
Above 960	500	3

** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.

(b) In the emission table above, the tighter limit applies at the band edges.

(c) The level of any unwanted emissions from an intentional radiator operating under these general provisions shall not exceed the level of the fundamental emission. For intentional radiators which operate under the provisions of other sections within this part and which are required to reduce their unwanted emissions to the limits specified in this table, the limits in this table are based on the frequency of the unwanted emission and not the fundamental frequency. However, the level of any unwanted emissions shall not exceed the level of the fundamental frequency.

(d) The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9-90 kHz, 110-490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.

(e) The provisions in §§ 15.31, 15.33, and 15.35 for measuring emissions at distances other than the distances specified in the above table, determining the frequency range over which radiated emissions are to be measured, and limiting peak emissions apply to all devices operated under this part.

(f) In accordance with § 15.33(a), in some cases the emissions from an intentional radiator must be measured to beyond the tenth harmonic of the highest fundamental frequency designed to be emitted by the intentional radiator because of the incorporation of a digital device. If measurements above the tenth harmonic are so required, the radiated emissions above the tenth harmonic shall comply with the general radiated emission limits applicable to the incorporated digital device, as shown in § 15.109 and as based on the frequency of the emission being measured, or, except for emissions contained in the restricted frequency bands shown in § 15.205, the limit on spurious emissions specified for the intentional radiator, whichever is the higher limit. Emissions which must be measured above the tenth harmonic of the highest fundamental frequency designed to be emitted by the

intentional radiator and which fall within the restricted bands shall comply with the general radiated emission limits in § 15.109 that are applicable to the incorporated digital device.

(g) Perimeter protection systems may operate in the 54-72 MHz and 76-88 MHz bands under the provisions of this section. The use of such perimeter protection systems is limited to industrial, business and commercial applications.

5.2.2. Method of Measurements

Ultratech Test Procedures, File # ULTR P001-2004 and ANSI C63.4 for measurement methods.

5.2.3. Test Data

Remarks:

- The measuring receiver shall be tuned over the frequency range 10 kHz to 1 GHz.
- All spurious emissions that are in excess of 20 dB below the specified limit shall be recorded.
- EUT was initially tested at 3m and the value measured at 3m shall be extrapolated as applicable to compare with limit and measurement distance specified in section 15.209(a).
- Extrapolation factor of 40dB/decade shall be used for frequencies below 30 MHz.

5.2.3.1. Fundamental Emissions

Remarks: • Field strength limit of the fundamental 127 kHz at 300m distance is $20 \cdot \log(2400/127) = 25.5 \text{ dB}\mu\text{V/m}$ • For frequency band 0.009- 0.490 MHz, the measured E-Field at 3m (column 2) will be extrapolated to 300m E-Field Level (column 3) using the extrapolation factor of $40 \cdot \log(3/300) = -80 \text{ dB}$					
Frequency (MHz)	Peak E-Field @ 3m (dB μ V/m)	Extrapolated E-Field Level @ 300m (dB μ V/m)	Antenna Plane (H/V)	§ 15.209 (a) Limits @ 300m (dB μ V/m)	Margin (dB)
0.127	49.35	-30.65	V	25.5	-56.2
0.127	46.83	-33.17	H	25.5	-58.7

5.2.3.2. Harmonic/Spurious Emissions

Remarks: - For frequency band 0.009- 0.490 MHz, the measured E-Field at 3m (column 2) will be extrapolated to 300m E-Field Level (column 3) using the extrapolation factor of $40 \cdot \log(3/300) = -80$ dB - For frequency bands 0.490-1.705 MHz and 1.705-30.0 MHz, the measured E-Field at 3m (column 2) will be extrapolated to 30m E-Field Level (column 3) using the extrapolation factor of $40 \cdot \log(3/30) = -40$ dB					
Frequency (MHz)	Peak E-Field @ 3m (dBµV/m)	Extrapolated E-Field Level (dBµV/m)	Antenna Plane (H/V)	§ 15.209 (a) Limits (dBµV/m)	Margin (dB)
0.009 - 0.490	*	*	H / V	25.7	*
0.490 - 1.705	*	*	H / V	45.7	*
1.705 - 30.0	*	*	H / V	29.5	*

* No emissions or harmonics were detected within 20 dB of the limit.

5.3. 20 dB BANDWIDTH [47 CFR 15.209 (a)]

5.3.1. Limit(s)

Emission bandwidth shall not be located in the restricted bands in 15.205 and the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz.

5.3.2. Method of Measurements

The measurements were performed in accordance with Ultratech Test Procedures, File # ULTR P001-2004 and ANSI C63.4:2009.

5.3.3. Test Data

Channel Frequency	20 dB Bandwidth
127 kHz	4.57 kHz

See the following plot for details.

Plot 5.3.3.1. 20 dB Bandwidth, Fc: 127 kHz

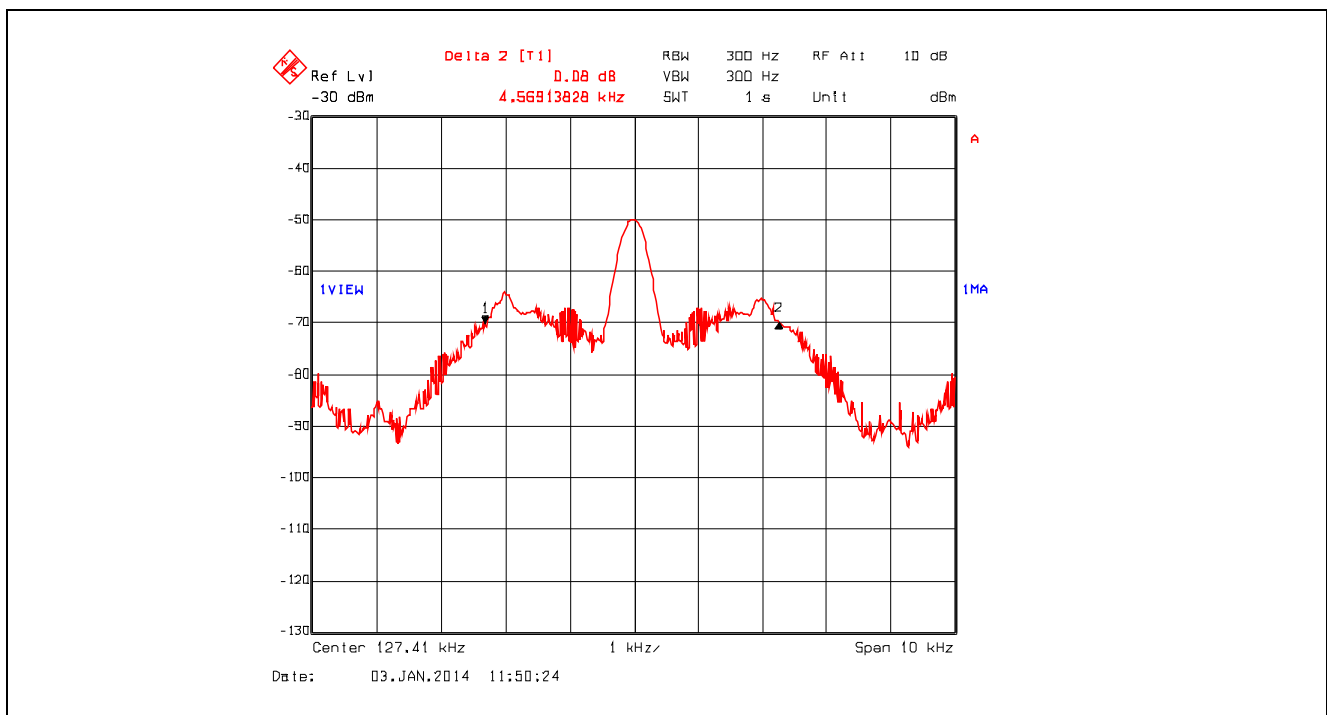


EXHIBIT 6. TEST EQUIPMENT LIST

Test Instruments	Manufacturer	Model No.	Serial No.	Frequency Range	Cal. Due Date
Spectrum Analyzer	Rohde & Schwarz	ESU40	100037	20 Hz – 40 GHz	07 Mar 2014
RF Amplifier	AH System	PAM-0118	225	20 MHz – 18 GHz	25 Mar 2014
Loop Antenna	EMCO	6502	9104-2611	10 kHz – 30 MHz	27 Aug 2015
Biconi-Log Antenna	ETS Lindgren	3142C	34792	26 – 3000 MHz	26 Jun 2014
Spectrum Analyzer	Rohde & Schwarz	FSEK30	100077	20 Hz – 40 GHz	08 Nov 2014
Spectrum Analyzer	Hewlett Packard	HP 8593EM	3412A00103	9 kHz–26.5 GHz	06 Feb 2014*
Attenuator	Pasternack	PE7010-20	-	DC–2 GHz	02 Jan 2015
L.I.S.N	EMCO	3825/2	8907-1531	0.01 -100 MHz	14 May 2014

*Equipment used on January 9, 2014.

ULTRATECH GROUP OF LABS

3000 Bristol Circle, Oakville, Ontario, Canada L6H 6G4
Tel. #: 905-829-1570, Fax. #: 905-829-8050, Email: vic@ultratech-labs.com, Website: <http://www.ultratech-labs.com>

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EXHIBIT 7. MEASUREMENT UNCERTAINTY

The measurement uncertainties stated were calculated in accordance with the requirements of CISPR 16-4-2 @ IEC:2003 and JCGM 100:2008 (GUM 1995) – Guide to the Expression of Uncertainty in Measurement.

7.1. LINE CONDUCTED EMISSION MEASUREMENT UNCERTAINTY

	Line Conducted Emission Measurement Uncertainty (9 kHz – 30 MHz):	Measured	Limit
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 1.44	± 1.8
U	Expanded uncertainty U: $U = 2u_c(y)$	± 2.89	± 3.6

7.2. RADIATED EMISSION MEASUREMENT UNCERTAINTY

	Radiated Emission Measurement Uncertainty @ 3m, Horizontal (30-1000 MHz):	Measured (dB)	Limit (dB)
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 2.39	± 2.6
U	Expanded uncertainty U: $U = 2u_c(y)$	± 4.79	± 5.2

	Radiated Emission Measurement Uncertainty @ 3m, Vertical (30-1000 MHz):	Measured (dB)	Limit (dB)
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 2.39	± 2.6
U	Expanded uncertainty U: $U = 2u_c(y)$	± 4.78	± 5.2

	Radiated Emission Measurement Uncertainty @ 3 m, Horizontal & Vertical (1 – 18 GHz):	Measured (dB)	Limit (dB)
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 1.87	Under consideration
U	Expanded uncertainty U: $U = 2u_c(y)$	± 3.75	Under consideration